

<b>Notice of References Cited</b>	Application/Control No. 10/760,060	Applicant(s)/Patent Under Reexamination JIN ET AL.	
	Examiner Nhan T. Le	Art Unit 2618	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,553,018	04-2003	Ichihara, Masaki	370/342
*	C	US-2005/0135312	06-2005	Montojo et al.	370/335
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	M	US-			

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**NON-PATENT DOCUMENTS**

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